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AMENDMENTS TO THE CLAIMS

1. (Currently amended) A resin for a photoresist composition, having a first structural unit that comprises a hydroxyl group bonded-to a carbon atom, wherein the first structural unit comprises comprising a -CR¹R²OH group only at a terminal of a principal chain of the resin, wherein R¹ and R² each represent, independently, an alkyl group, halogen atom, or halogenated alkyl group, and at least one of R¹ and R² is an electron attractive group selected from the group consisting of halogen atoms and halogenated alkyl groups, wherein said -CR¹R²OH group is bonded at a principal chain terminal of a polymer of said resin.

- 2. (Canceled).
- 3. **(Original)** A resin for a photoresist composition according to claim 1, wherein said electron attractive group is a fluorine atom or a fluorinated alkyl group.
- 4. (Previously presented) A resin for a photoresist composition according to claim 1, wherein a proportion of the first structural unit comprising said -CR¹R²OH group is at least 1 mol%, relative to a combined 100 mol% of all structural units other than said first structural unit within said resin for a photoresist composition.
- 5. (Canceled)
- 6. (Canceled)
- 7. **(Previously presented)** A resin for a photoresist composition according to claim 1, further comprising an acid dissociable, dissolution inhibiting group.
- 8. (Original) A resin for a photoresist composition according to claim 7, further comprising (a1) a structural unit derived from a (meth)acrylate ester having an acid dissociable, dissolution inhibiting group, and (a2) a structural unit derived from a (meth)acrylate ester having a lactone ring.

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- 9. (Original) A resin for a photoresist composition according to claim 8, further comprising (a3) a structural unit derived from a (meth)acrylate ester having a hydroxyl group.
- 10. **(Previously presented)** A resin for a photoresist composition according to claim 1, with a weight average molecular weight of no more than 12,000.
- 11. **(Previously presented)** A photoresist composition, comprising a resin for a photoresist composition according to claim 1.
- 12. **(Original)** A photoresist composition according to claim 11, further comprising an acid generator as a component (B).
- 13. **(Original)** A photoresist composition according to claim 12, comprising as said component (B), (b-0) an onium salt that comprises a fluorinated alkylsulfonate ion as an anion.
- 14. **(Original)** A photoresist composition according to claim 12, comprising as said component (B), a sulfonium compound represented by either of general formulas (b-1) and (b-2) shown below:

$$R^2 - S^+ - N \qquad X \qquad \cdots (b-1)$$

$$R^{1}$$
 $O_{2}S-Y$
 $R^{2}-S^{+}$ N ... (b-2)
 R^{3} $O_{2}S-Z$

wherein, X represents an alkylene group of 2 to 6 carbon atoms in which at least one hydrogen atom has been substituted with a fluorine atom; Y and Z each represent, independently, an alkyl group of 1 to 10 carbon atoms in which at least one hydrogen atom has been substituted with a

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fluorine atom; R^1 to R^3 each represent, independently, an aryl group or an alkyl group, and at least one of R^1 to R^3 is an aryl group.

- 15. **(Original)** A photoresist composition according to claim 14, further comprising as said component (B), (b-0) an onium salt that comprises a fluorinated alkylsulfonate ion as an anion.
- 16. **(Original)** A photoresist composition according to claim 11, further comprising a nitrogen-containing organic compound.
- 17. **(Previously presented)** A method for forming a resist pattern, using a photoresist composition according to claim 11, comprising the steps of:

applying the photoresist composition to a surface of a substrate; performing selective exposure through a desired mask pattern; and performing developing to form a resist pattern.

- 18. (**Previously presented**) A resin for a photoresist composition according to claim 1, wherein a proportion of the first structural units constituting said resin is 1-5 mol%, relative to a combined 100 mol% of all structural units other than said first structural units within said resin.
- 19. (**Previously presented**) A resin for a photoresist composition according to claim 1, wherein the first structural unit which includes the carbon atom in the α -position of said hydroxyl group having at least one electron attractive group is substantively bonded only to the polymer terminal.
- 20. (**Previously presented**) A resin for a photoresist composition according to claim 5, wherein a proportion of the first structural units which have the substituents with a pKa value between 6 and 12 constituting said resin is 1-5 mol% relative to a combined 100 mol% of all structural units other than said first structural units within said resin.

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21. (**Previously presented**) A resin for a photoresist composition according to claim 5, wherein the substituents with a pKa value between 6 and 12 are substantively bonded only to the polymer terminal.

- 22. (New) The resin for a photoresist composition according to claim 1, wherein a -S-(CH₂)_m-C(CF₃)₂-OH group is introduced at a terminal of a principal chain of the resin, wherein m represents an integer from 2 to 4.
- 23. (New) A resin for a photoresist composition, comprising: a -CR¹R²OH group which is introduced at a terminal of a principal chain of the resin; and a structural unit derived from a (meth)acrylate ester containing an acid dissociable, dissolution inhibiting group, wherein R¹ and R² each represent, independently, an alkyl group, a halogen atom, or a halogenated alkyl group, and at least one of R¹ and R² is an electron attractive group selected from the group consisting of halogen atoms and halogenated alkyl groups.
- 24. (New) The resin for a photoresist composition according to claim 23, wherein a -S-(CH₂)_m-C(CF₃)₂-OH group is introduced at a terminal of a principal chain of the resin, wherein m represents an integer from 2 to 4.